

September 1998

54ACTQ10 Quiet Series Triple 3-Input NAND Gate

General Description

The 'ACTQ10 contains three, 3-input NAND gates and utilizes NSC Quiet Series technology to guarantee quiet output switching and improved dynamic threshold performance. FACT Quiet Series®features GTO® output control and undershoot corrector in addition to a split ground bus for superior ACMOS performance.

- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Improved latch-up immunity
- Minimum 2 kV ESD protection
- Outputs source/sink 24 mA
- 'ACTQ10 has TTL-compatible inputs
- Standard Microcircuit Drawing (SMD) 5962-9218201

Features

■ I_{CC} reduced by 50%

Logic Symbol Connection Diagrams IEEE/IEC Pin Assignment for DIP and Flatpak Во Co В C_1 ō, B_2 Pin Names Description Pin Assignment for LCC $A_n,\,B_n,\,C_n$ Inputs C₁ NC B₁ NC A₁ 8 7 6 5 4 \overline{O}_n Outputs ■ 3B₀ GND 10 NC 11 2 A₀ 1 NC 20 V_{CC} 0₂ 12 C₂ 13 19 C₀ 14 15 16 17 18 B₂ NC A₂ NC $\overline{\text{O}}_{\text{O}}$ DS010892-3

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FACT® and FACT Quiet Series® are trademarks of Fairchild Semiconductor Corporation

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V_{CC}) -0.5V to +7.0V DC Input Diode Current (IIK) $V_1 = -0.5V$ -20 mA $\dot{V_{I}} = V_{CC} + 0.5V$ +20 mA DC Input Voltage (V_I) -0.5V to $V_{\rm CC}$ + 0.5V DC Output Diode Current (I_{OK}) $V_{O} = -0.5V$ -20 mA $V_O = V_{CC} + 0.5V$ +20 mA DC Output Voltage (V_O) -0.5V to $V_{\rm CC}$ + 0.5V DC Output Source or Sink Current (IO) ±50 mA DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND}) ±50 mA Storage Temperature (T_{STG}) -65°C to +150°C DC Latch-Up Source or Sink Current ±300 mA Junction Temperature (T_{.1})

CDIP 175°C

Recommended Operating Conditions (Note 2)

Supply Voltage (V_{CC})

 $\begin{tabular}{lll} 'ACTQ & 4.5V to 5.5V \\ Input Voltage (V_I) & 0V to V_{CC} \\ Output Voltage (V_O) & 0V to V_{CC} \\ \end{tabular}$

Operating Temperature (T_A)

Minimum Input Edge Rate (dV/dt)

'ACTQ Devices 125 mV/ns

 $\rm V_{IN}$ from 0.8V to 2.0V $\rm V_{CC}$ @ 4.5V, 5.5V

Note 1: Absolute maximum ratings are values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation outside of databook specifications.

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Note 2: All commercial packaging is not recommended for applications requiring greater than 2000 temperature cycles from -40°C to +125°C.

DC Characteristics for 'ACTQ Family Devices

			54ACTQ		
Symbol	Parameter	V _{cc}	T _A =	Units	Conditions
		(V)	-55°C to +125°C		
			Guaranteed Limits	1	
V _{IH}	Minimum High Level	4.5	2.0	V	V _{OUT} = 0.1V
	Input Voltage	5.5	2.0		or V _{CC} – 0.1V
V _{IL}	Maximum Low Level	4.5	0.8	V	V _{OUT} = 0.1V
	Input Voltage	5.5	0.8		or V _{CC} – 0.1V
V _{OH}	Minimum High Level	4.5	4.4	V	I _{OUT} = -50 μA
	Output Voltage	5.5	5.4		
					(Note 3)
					$V_{IN} = V_{IL} \text{or } V_{IH}$
		4.5	3.70	V	$I_{OH} = -24 \text{ mA}$
		5.5	4.70		I _{OH} =-24 mA
V_{OL}	Maximum Low Level	4.5	0.1	V	I _{OUT} = 50 μA
	Output Voltage	5.5	0.1		
					(Note 3)
					$V_{IN} = V_{IL} \text{or } V_{IH}$
		4.5	0.50	V	I _{OL} = 24 mA
		5.5	0.50		I _{OL} = 24 mA
I _{IN}	Maximum Input	5.5	±1.0	μA	$V_I = V_{CC}$, GND
	Leakage Current				
I _{CCT}	Maximum	5.5	1.6	mA	$V_{I} = V_{CC} - 2.1V$
	I _{CC} /Input				
I _{OLD}	Minimum Dynamic	5.5	50	mA	V _{OLD} = 1.65V Max
I _{OHD}	Output Current (Note 4)	5.5	-50	mA	V _{OHD} = 3.85V Min
I _{cc}	Maximum Quiescent	5.5	40.0	μA	V _{IN} = V _{CC}
	Supply Current				or GND (Note 5)

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DC Characteristics for 'ACTQ Family Devices (Continued)

Symbol	Parameter	V _{cc} (V)	54ACTQ T _A = -55°C to +125°C Guaranteed Limits	Units	Conditions
V _{OLP}	Quiet Output	5.0	1.5	V	
	Maximum Dynamic V _{OL}				(Note 6)
V _{OLV}	Quiet Output	5.0	-1.2	V	
	Minimum Dynamic V _{OL}				(Note 6)

 $\textbf{Note 3:} \ \ \textbf{All outputs loaded; thresholds on input associated with output under test.}$

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

Note 5: I_{CC} for 54ACTQ @ 25° C is identical to 74ACTQ @ 25° C.

Note 6: Max number of outputs defined as (n). Data inputs are 0V to 3V. One output @ GND.

Note 7: Max number of data inputs (n) switching. (n-1) inputs switching 0V to 3V ('ACTQ). Input-under-test switching: 3V to threshold (V ILD), 0V to threshold (V IHD), f = 1 MHZ.

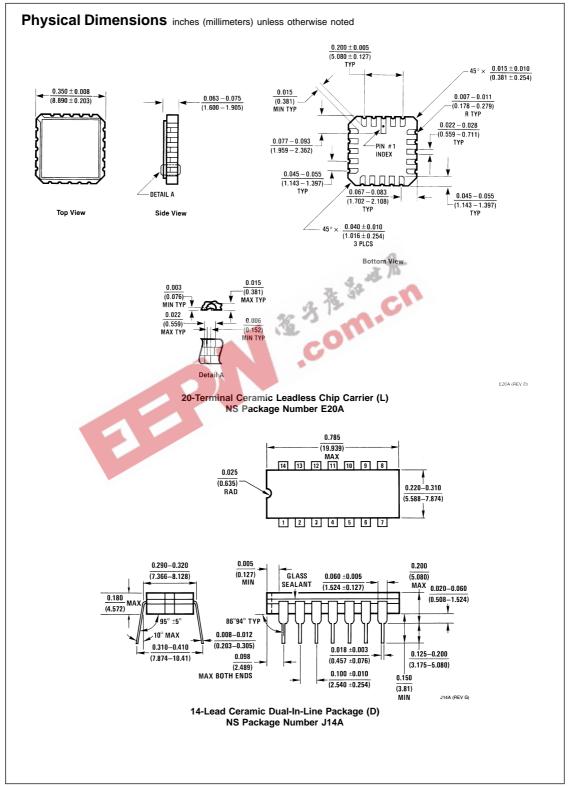
AC Electrical Characteristics

AC Elec	trical Characteristic	es		4	
			54	ACTQ	
Symbol	Parameter	V _{cc} (V) (Note 8)	T _A = -55°C to +125°C C _L = 50 pF		Units
		1	Min	Max	
t _{PLH}	Propagation Delay	5.0	2.0	9.5	ns
t _{PHL}	Propagation Delay	5.0	2.0	9.5	ns

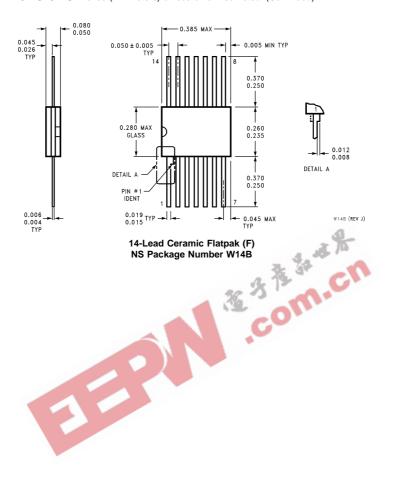
Note 8: Voltage Range 5.0 is 5.0V ±0.5V.

Capacitance

-				
Symbol	Parameter	Тур	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN
C _{PD}	Power Dissipation	85	pF	V _{CC} = 5.0V
	Capacitance			



Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



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